

AUTOMOTIVE GRADE

AUIRF1324S-7P

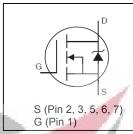
Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- · Fast Switching
- Repetitive Avalanche Allowed up to Timax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and wide variety of other applications.

V _{DSS}	24V
R _{DS(on)} typ.	0.8mΩ
max.	1.0mΩ
D (Silicon Limited)	429A①
D (Package Limited)	240A





G	D	S
Gate	Drain	Source

Page Part Number	Dockage Type	Standar	d Pack	Ordershie Bert Number
Base Part Number	ase Part Number Package Type Form		Quantity	Orderable Part Number
AUIRF1324S-7P	D ² Pak 7 Pin	Tube	50	AUIRF1324S-7P

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter Parame	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	429①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	303①	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	240	Α
I _{DM}	Pulsed Drain Current ②	1640	
P _D @T _C = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 3	230	mJ
I _{AR}	Avalanche Current ②	See Fig.14,15, 18a, 18b	Α
E _{AR}	Repetitive Avalanche Energy	KUNIC	mJ
dv/dt	Peak Diode Recovery @	1.6	V/ns
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.50	°C/W
$R_{ hetaJA}$	Junction-to-Ambient ®		40	C/VV

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	24			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.023		V/°C	Reference to 25°C, I _D = 5mA ©
R _{DS(on)}	Static Drain-to-Source On-Resistance		0.80	1.0	mΩ	V _{GS} = 10V, I _D = 160A ⑤
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	190			S	V _{DS} = 15V, I _D = 160A
R_G	Gate Resistance		3.0		Ω	
	Drain to Course Lookens Current			20		V_{DS} =24V, V_{GS} = 0V
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	V_{DS} =24V, V_{GS} = 0V V_{DS} =19V, V_{GS} = 0V, T_{J} =125°C
1	Gate-to-Source Forward Leakage			200	nA	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-200	IIA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	(i i			,		
Q_g	Total Gate Charge		180	252		$I_D = 75A$
Q_{gs}	Gate-to-Source Charge		47		0	V _{DS} = 12V
Q_{gd}	Gate-to-Drain Charge		58	_	nC	V _{DS} = 12V V _{GS} = 10V⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		122	-4		
$t_{d(on)}$	Turn-On Delay Time		19	-		V _{DD} = 16V
t _r	Rise Time		240		no	I _D = 160A
$t_{d(off)}$	Turn-Off Delay Time		86		ns	$R_G = 2.7\Omega$
t _f	Fall Time		93			V _{GS} = 10V ^⑤
C _{iss}	Input Capacitance	~_	7700			$V_{GS} = 0V$
Coss	Output Capacitance		3380			$V_{DS} = 19V$
C_{rss}	Reverse Transfer Capacitance		1930	+	pF	f = 1.0MHz, See Fig. 5
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		4780	4		V _{GS} = 0V, V _{DS} = 0V to 19V⑦
C _{oss eff.(TR)}	Effective Output Capacitance (Time Related)		4970	Æ.		$V_{GS} = 0V$, $V_{DS} = 0V$ to 19V®
			100			

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			429①		MOSFET symbol
Is	(Body Diode)			4290		showing the
1	Pulsed Source Current			1640	Α	integral reverse
I _{SM}	(Body Diode) ②	T AME		1040		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 160A, V_{GS} = 0V$ \$
	Daversa Dassvery Time		71	107	ns	$T_J = 25^{\circ}C$ $V_{DD} = 20V$
t _{rr}	Reverse Recovery Time		74	110		$T_J = 125^{\circ}C$ $I_F = 160A$,
	Deverse Recevery Charge		83	120	nC	$T_J = 25^{\circ}C$ di/dt = 100A/µs $\$$
Q_{rr}	Reverse Recovery Charge		92	140	IIC	$T_J = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		2.0		Α	T _J = 25°C
t _{on}	Forward Turn-On Time	Intrinsic	turn-or	time is	negligil	ole (turn-on is dominated by L _S +L _D)

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 240A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- \odot Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 0.018mH, $R_G = 25\Omega$, $I_{AS} = 160A$, $V_{GS} = 10V$. Part not recommended for use above this value.
- \bigcirc Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- \odot C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- \mathfrak{G} R_θ is measured at T_J approximately 90°C.



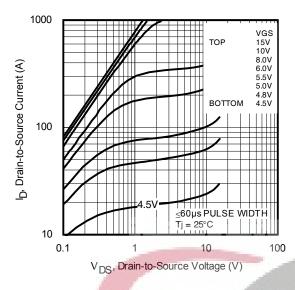


Fig. 1 Typical Output Characteristics

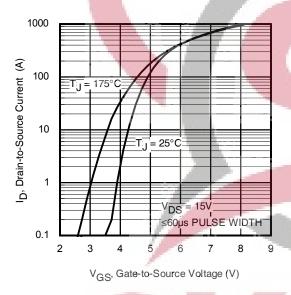


Fig. 3 Typical Transfer Characteristics

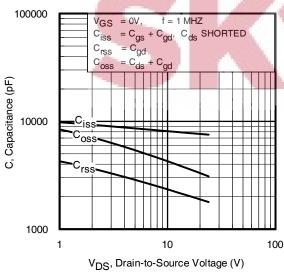


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

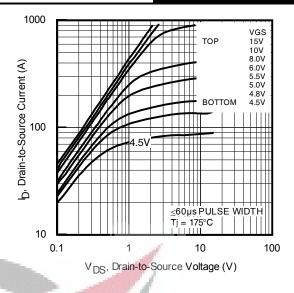


Fig. 2 Typical Output Characteristics

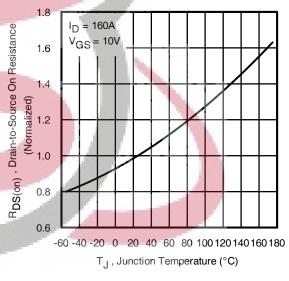


Fig. 4 Normalized On-Resistance vs. Temperature

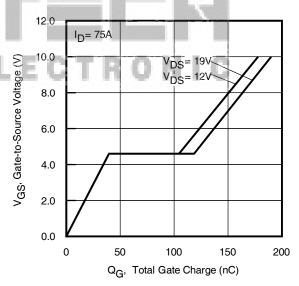
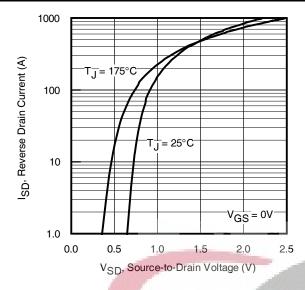


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage





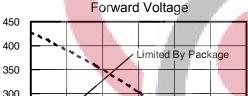


Fig. 7 Typical Source-to-Drain Diode

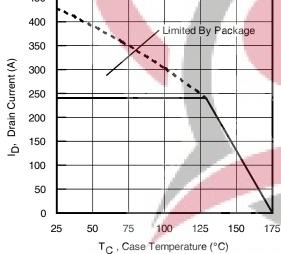


Fig 9. Maximum Drain Current vs. Case Temperature

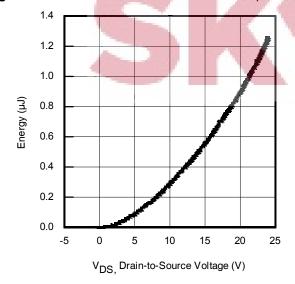


Fig 11. Typical Coss Stored Energy

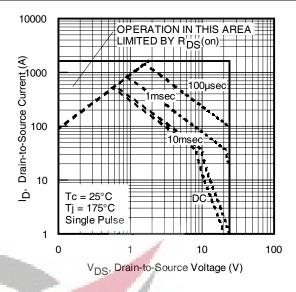


Fig 8. Maximum Safe Operating Area

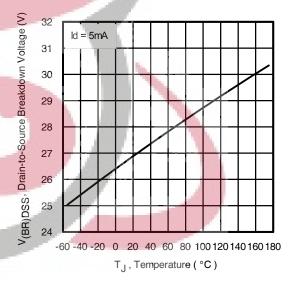


Fig 10. Drain-to-Source Breakdown Voltage

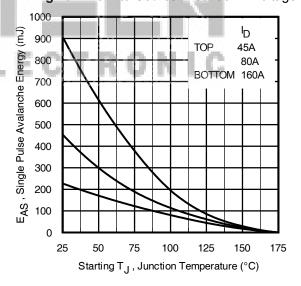


Fig 12. Maximum Avalanche Energy vs. Drain Current



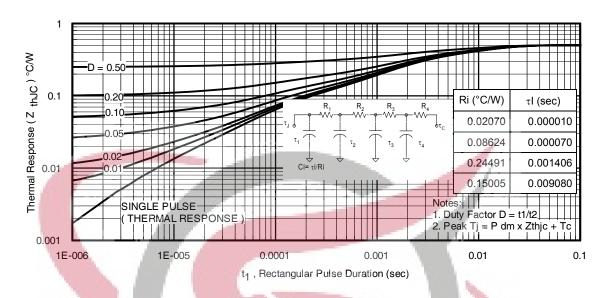


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

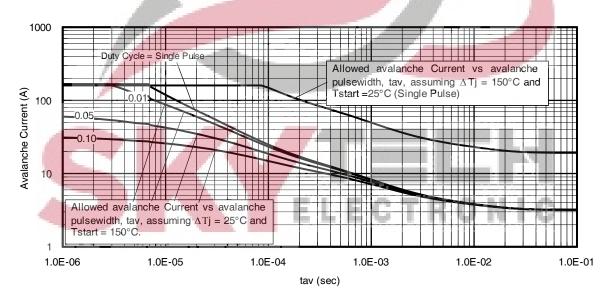
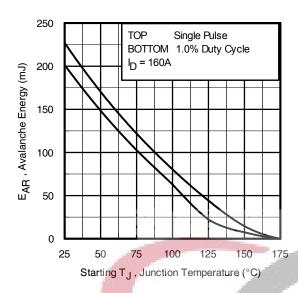


Fig 14. Avalanche Current vs. Pulse width





Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 13, 14).

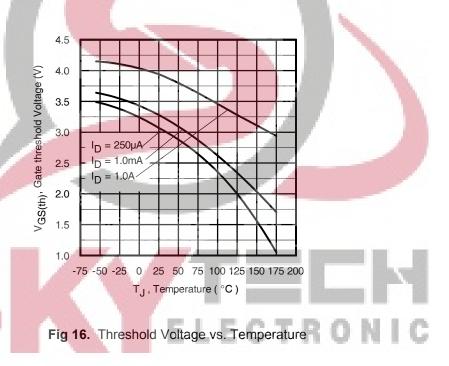
tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \Delta \text{T} / \text{ Z}_{thJC} \\ I_{av} &= 2\Delta \text{T} / \text{ [} 1.3 \cdot \text{BV} \cdot \text{Z}_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

Fig 15. Maximum Avalanche Energy vs. Temperature





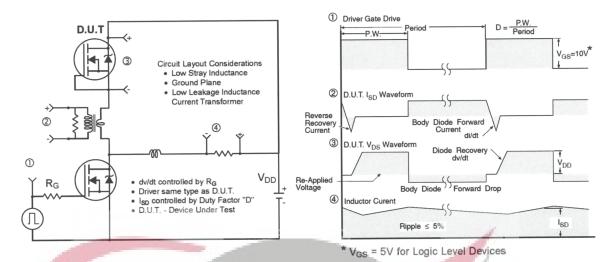


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

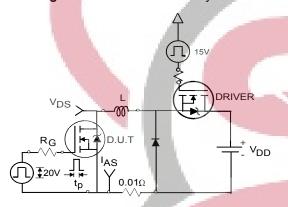


Fig 18a. Unclamped Inductive Test Circuit

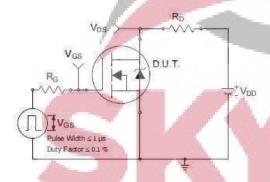


Fig 19a. Switching Time Test Circuit

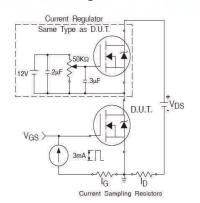


Fig 20a. Gate Charge Test Circuit

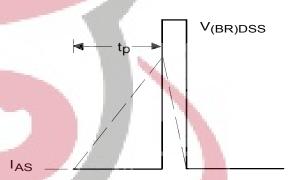


Fig 18b. Unclamped Inductive Waveforms

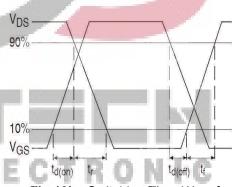


Fig 19b. Switching Time Waveforms

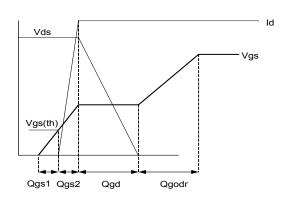
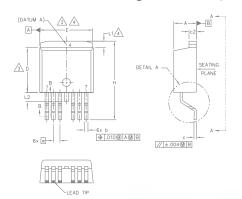
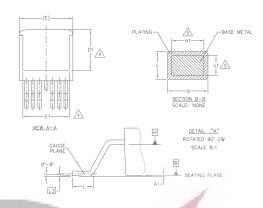


Fig 20b. Gate Charge Waveform



D²Pak - 7 Pin Package Outline (Dimensions are shown in millimeters (inches))



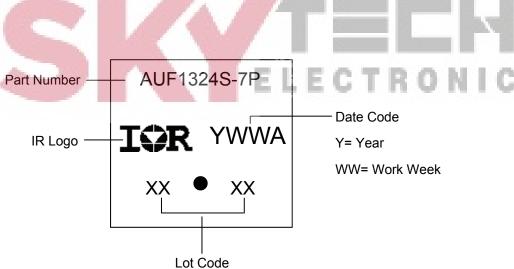


S Y M		DIMEN	SIONS		N
B	MILLIM	ETERS	INC	HES	O T E
L	MIN.	MAX.	S		
А	4.06	4.83	.160	.190	
A1	_	0.254		.010	
Ь	0.51	0.99	.020	.036	
b1	0.51	0.89	.020	.032	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	7.42	.270	.292	4
E	9.65	10.54	.380	.415	3,4
E1	6.22	8.48	.245	.334	4
е	1.27	BSC	.050	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

NOTES.

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO 263CB. EXCEPT FOR DIMS. E, E1 & D1.

D²Pak - 7 Pin Part Marking Information





Qualification Information

400000	ion inioniation					
		Automotive (per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher				
		Automotive level.				
Moisture	Sensitivity Level	D ² -Pak 7 Pin	MSL1			
			Class M4 [†]			
	Machine Model	AEC-Q101-002				
FOD	Liver on Dady Madel	Class H3A [†]				
ESD	Human Body Model	AEC-Q101-001				
Channel Device Medal		Class C3 [†]				
	Charged Device Model		AEC-Q101-005			
RoHS Cor	mpliant	Yes				

[†] Highest passing voltage.

Revision History

Date		Comments
	•	Updated datasheet with corporate template
9/30/2015	•	Corrected ordering table on page 1.
	•	Updated typo on GFS on page 2.

Published by Infineon Technologies AG 81726 München, Germany © Infineon Technologies AG 2015 All Rights Reserved.

IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may <u>not</u> be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Infineon: AUIRF1324S-7P



Published by WWW.\$KYTECH.ir